FAIRCHILD SEMICONDUCTOR™

April 1988
Revised August 1999

74F401
CRC Generator/Checker

General Description

The 74F401 Cycle Redundancy Check (CRC) Generator/Checker provides an advanced tool for implementing the most widely used error detection scheme in serial digital data handling systems. A 3-bit control input selects one-of-eight generator polynomials. The list of polynomials includes CRC-16 and CRC-CCITT as well as their reciprocals (reverse polynomials). Automatic right justification is incorporated for polynomials of degree less than 16. Separate clear and preset inputs are provided for floppy disk and other applications. The Error output indicates whether or not a transmission error has occurred. Another control input inhibits feedback during check word transmission. The 74F401 is fully compatible with all TTL families.

Features

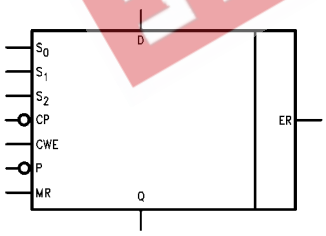
- Eight selectable polynomials
- Error indicator
- Separate preset and clear controls
- Automatic right justification
- Fully compatible with all TTL logic families
- 14-pin package
- 9401 equivalent
- Typical applications:
  - Floppy and other disk storage systems
  - Digital cassette and cartridge systems
  - Data communication systems

Ordering Code:

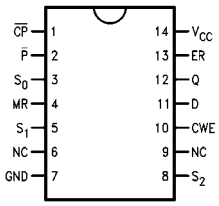
Order Number	Package Number	Package Description
74F401SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74F401PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Unit Loading/Fan Out

Pin Names	Description	U.L. HIGH/LOW	Input I_{IH}/I_{IL} Output I_{OH}/I_{OL}
S_0–S_2	Polynomial Select Inputs	1.0/1.0	20 µA/–0.6 mA
D	Data Input	1.0/1.0	20 µA/–0.6 mA
$\overline{CP}$	Clock Input (Operates on HIGH-to-LOW Transition)	1.0/1.0	20 µA/–0.6 mA
CWE	Check Word Enable Input	1.0/1.0	20 µA/–0.6 mA
$\overline{P}$	Preset (Active LOW) Input	1.0/1.0	20 µA/–0.6 mA
MR	Master Reset (Active HIGH) Input	1.0/1.0	20 µA/–0.6 mA
Q	Data Output	50/33.3	–1 mA/20 mA
ER	Error Output	50/33.3	–1 mA/20 mA

Functional Description

The 74F401 is a 16-bit programmable device which operates on serial data streams and provides a means of detecting transmission errors. Cyclic encoding and decoding schemes for error detection are based on polynomial manipulation in modulo arithmetic. For encoding, the data stream (message polynomial) is divided by a selected polynomial. This division results in a remainder which is appended to the message as check bits. For error checking, the bit stream containing both data and check bits is divided by the same selected polynomial. If there are no detectable errors, this division results in a zero remainder. Although it is possible to choose many generating polynomials of a given degree, standards exist that specify a small number of useful polynomials. The 74F401 implements the polynomials listed in Table 1 by applying the appropriate logic levels to the select pins S_0, S_1 and S_2.

The 74F401 consists of a 16-bit register, a Read Only Memory (ROM) and associated control circuitry as shown in the block diagram. The polynomial control code presented at inputs S_0, S_1 and S_2 is decoded by the ROM, selecting the desired polynomial by establishing shift mode operation on the register with Exclusive OR gates at appropriate inputs. To generate the check bits, the data stream is entered via the Data inputs (D), using the HIGH-to-LOW transition of the Clock input ($\overline{CP}$). This data is gated with the most significant output (Q) of the register, and controls the Exclusive OR gates Figure 1. The Check Word Enable (CWE) must be held HIGH while the data is being entered. After the last data bit is entered, the CWE is brought LOW and the check bits are shifted out of the register and appended to the data bits using external gating Figure 2.

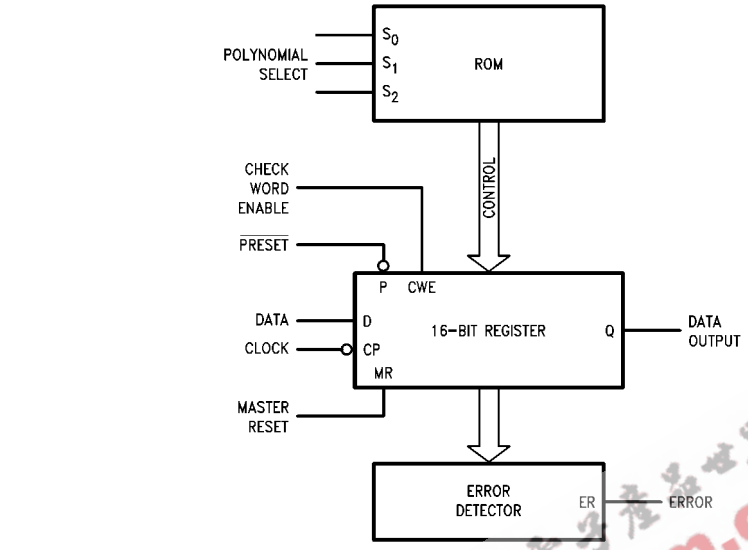
To check an incoming message for errors, both the data and check bits are entered through the D input with the CWE input held HIGH. The 74F401 is not in the data path, but only monitors the message. The Error Output becomes valid after the last check bit has been entered into the 74F401 by a HIGH-to-LOW transition of $\overline{CP}$. If no detectable errors have occurred during the data transmission, the resultant internal register bits are all LOW and the Error Output (ER) is LOW. If a detectable error has occurred, ER is HIGH.

A HIGH on the Master Reset input (MR) asynchronously clears the register. A LOW on the Preset input ($\overline{P}$) asynchronously sets the entire register if the control code inputs specify a 16-bit polynomial; in the case of 12- or 8-bit check polynomials only the most significant 12 or 8 register bits are set and the remaining bits are cleared.

TABLE 1.

Select Code S_2	Select Code S_1	Select Code S_0	Polynomial	Remarks
L	L	L	$X^{16} + X^{15} + X^2 + 1$	CRC-16
L	L	H	$X^{16} + X^{14} + X + 1$	CRC-16 REVERSE
L	H	L	$X^{16} + X^{15} + X^{13} + X^7 + X^4 + X^2 + X^1 + 1$	
L	H	H	$X^{12} + X^{11} + X^3 + X^2 + X + 1$	CRC-12
H	L	L	$X^8 + X^7 + X^5 + X^4 + X + 1$	
H	L	H	$X^8 + 1$	LRC-8
H	H	L	$X^{16} + X^{12} + X^5 + 1$	CRC-CCITT
H	H	H	$X^{16} + X^{11} + X^4 + 1$	CRC-CCITT REVERSE

Block Diagram



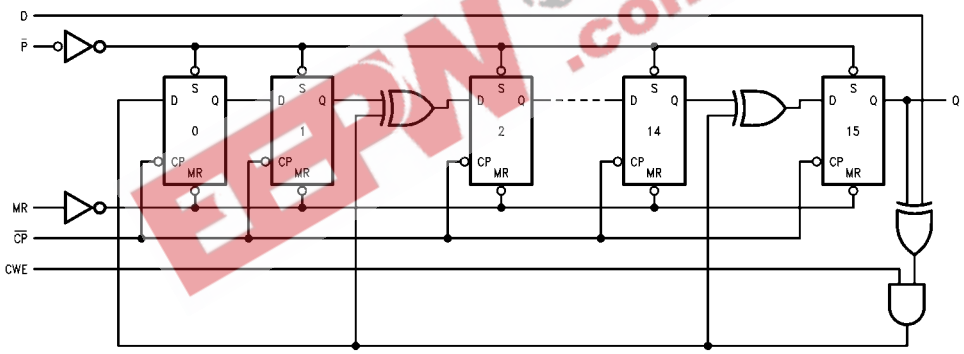


FIGURE 1. Equivalent Circuit for $X^{16} + X^{15} + X^2 + 1$

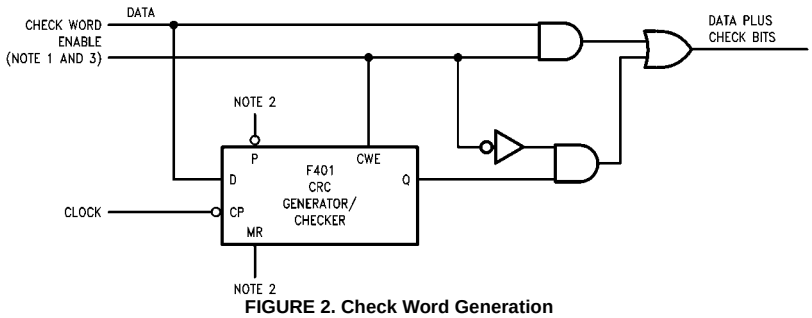


FIGURE 2. Check Word Generation

Note 1: Check word Enable is HIGH while data is being clocked, LOW while transmission of check bits.

Note 2: 74F401 must be reset or preset before each computation.

Note 3: CRC check bits are generated and appended to data bits.

Absolute Maximum Ratings(Note 4)

Storage Temperature	−65°C to +150°C
Ambient Temperature under Bias	−55°C to +125°C
Junction Temperature under Bias	−55°C to +150°C
V_{CC} Pin Potential to Ground Pin	−0.5V to +7.0V
Input Voltage (Note 5)	−0.5V to +7.0V
Input Current (Note 5)	−30 mA to +5.0 mA
Voltage Applied to Output	
in HIGH State (with V_{CC} = 0V)	
Standard Output	−0.5V to V_{CC}
3-STATE Output	−0.5V to +5.5V
Current Applied to Output	
in LOW State (Max)	twice the rated I_{OL} (mA)

Recommended Operating Conditions

Free Air Ambient Temperature	0°C to +70°C
Supply Voltage	+4.5V to +5.5V

Note 4: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 5: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Parameter	Min	Typ	Max	Units	V_{CC}	Conditions
V_{IH}	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V_{IL}	Input LOW Voltage			0.8	V		Recognized as a LOW Signal
V_{CD}	Input Clamp Diode Voltage			−1.2	V	Min	I_{IN} = −18 mA
V_{OH}	Output HIGH 10% V_{CC}	2.5			V	Min	I_{OH} = −1 mA
	Voltage 5% V_{CC}	2.7					I_{OH} = −1 mA
V_{OL}	Output LOW Voltage 10% V_{CC}			0.5	V	Min	I_{OL} = 20 mA
I_{IH}	Input HIGH Current			5.0	µA	Max	V_{IN} = 2.7V
I_{BVI}	Input HIGH Current Breakdown Test			7.0	µA	Max	V_{IN} = 7.0V
I_{CEX}	Output HIGH Leakage Current			50	µA	Max	V_{OUT} = V_{CC}
V_{ID}	Input Leakage Test	4.75			V	0.0	I_{ID} = 1.9 µA All Other Pins Grounded
I_{OD}	Output Leakage Circuit Current			3.75	µA	0.0	V_{IOD} = 150 mV All Other Pins Grounded
I_{IL}	Input LOW Current			−0.6	mA	Max	V_{IN} = 0.5V
I_{OS}	Output Short-Circuit Current	−60		−150	mA	Max	V_{OUT} = 0V
I_{CCH}	Power Supply Current		70	105	mA	Max	V_O = HIGH

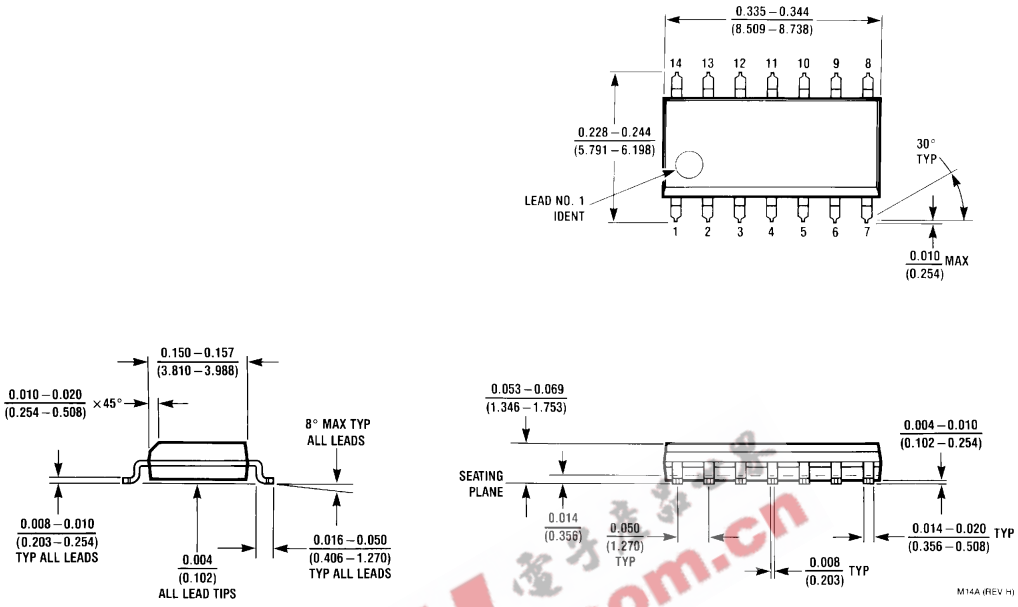
AC Electrical Characteristics

Symbol	Parameter	$T_A = +25°C$, $V_{CC} = +5.0V$, $C_L = 50$ pF			$T_A = 0°C$ to $+70°C$, $V_{CC} = +5.0V$, $C_L = 50$ pF		Units
		Min	Typ	Max	Min	Max	
f_{MAX}	Maximum Clock Frequency	100			85		MHz
t_{PLH} t_{PHL}	Propagation Delay $\overline{CP}$ to Q	4.5 4.0		11.5 10.0	4.5 4.0	13.5 11.0	ns
t_{PHL}	Propagation Delay MR to Q	3.0		7.5	3.0	8.0	ns
t_{PLH}	Propagation Delay $\overline{P}$ to Q	3.0		8.5	3.0	9.5	ns
t_{PHL}	Propagation Delay MR to ER	3.5		11.0	3.5	12.0	ns
t_{PLH}	Propagation Delay $\overline{P}$ to ER	3.0		8.5	3.0	10.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\overline{CP}$ to ER	5.0 4.5		13.0 11.5	5.0 4.5	14.5 12.5	ns

AC Operating Requirements

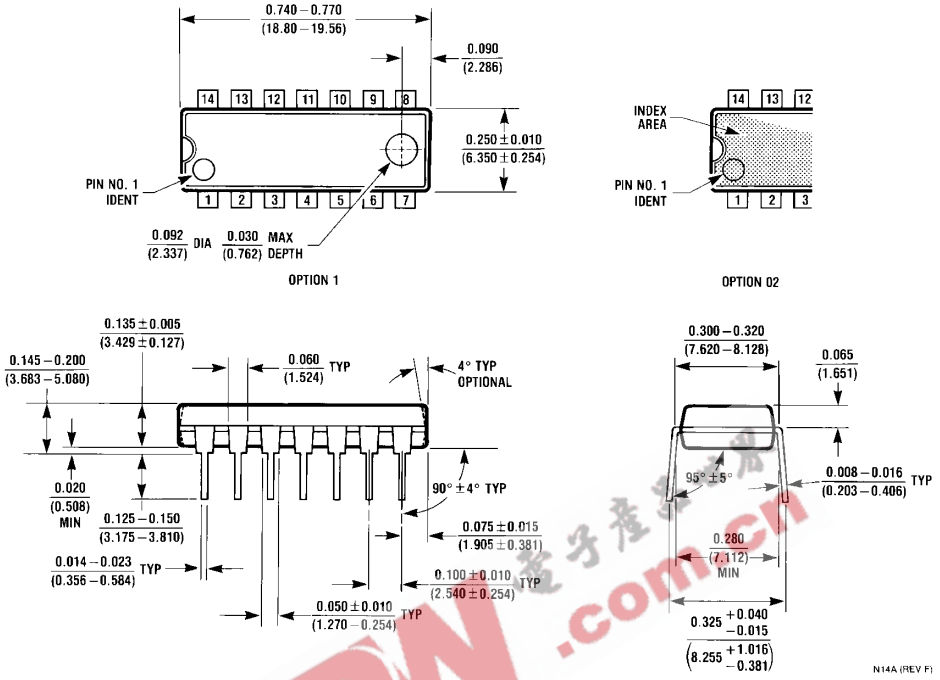
Symbol	Parameter	$T_A = +25°C$, $V_{CC} = +5.0V$		$T_A = 0°C$ to $+70°C$, $V_{CC} = +5.0V$		Units
		Min	Max	Min	Max	
$t_S(H)$ $t_S(L)$	Set-up Time, HIGH or LOW D to $\overline{CP}$	5.0 5.0		5.5 5.5		
$t_S(H)$ $t_S(L)$	Set-up Time, HIGH or LOW CWE to $\overline{CP}$	4.0 4.0		4.5 4.5		ns
$t_H(H)$ $t_H(L)$	Hold Time, HIGH or LOW D and CWE to $\overline{CP}$	2.0 2.0		2.0 2.0		
$t_W(L)$	$\overline{P}$ Pulse Width, LOW	7.0		8.0		ns
$t_W(H)$ $t_W(L)$	Clock Pulse Width, HIGH or LOW	5.0 5.0		6.0 6.0		ns
$t_W(H)$	MR Pulse Width, HIGH	5.0		5.5		ns
t_{REC}	Recovery Time MR to $\overline{CP}$	4.0		4.5		ns
t_{REC}	Recovery Time $\overline{P}$ to $\overline{CP}$	2.0		2.0		ns

Physical Dimensions inches (millimeters) unless otherwise noted



14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
Package Number M14A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
Package Number N14A